

<b>Notice of References Cited</b>		Application/Control No. 10/554,222	Applicant(s)/Patent Under Reexamination MIYAMA ET AL.	
		Examiner Alix Elizabeth Echelmeyer	Art Unit 1795	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-7,214,756	05-2007	Nomura et al.	528/30
*	B US-2004/0197613	10-2004	Curlier et al.	429/014
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	WO03/041091	10-2003	WIPO	Nomura et al.	
O	JP 2002-309016	10-2002	Japan	Honma et al.	
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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